

Description

The DMP3021SFVW-7 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = -30V I_{D} = -50 A$

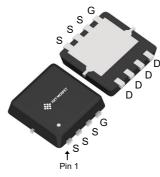
 $R_{DS(ON)}$ < 13m Ω @ V_{GS} =-10V

Application

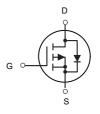
Battery protection

Load switch

Uninterruptible power supply



DFN3X3-8L (Power-33-8)



P-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
DMP3021SFVW-7	DFN3X3-8L(Power-33-8)	HXY MOSFET	5000

Absolute Maximum Ratings (TC=25°C unless otherwise specified)

		Rating		Units	
Symbol	Parameter	10s	Steady State	Units	
VDS	Drain-Source Voltage	-30		V	
VGS	Gate-Source Voltage	±20		V	
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-50		Α	
I _D @T _C =100℃	Continuous Drain Current, V _{GS} @ -10V ¹	-27		Α	
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-14.3	-9	Α	
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ -10V ¹	-11.4	-7.2	Α	
IDM	Pulsed Drain Current ²	-130		Α	
EAS	Single Pulse Avalanche Energy ³	125		mJ	
IAS	Avalanche Current	-50		Α	
P _D @T _C =25°C	Total Power Dissipation ⁴	37		W	
P _D @T _A =25°C	Total Power Dissipation ⁴	4.2	1.67	W	
TSTG	Storage Temperature Range	-55 to 150		°C	
TJ	Operating Junction Temperature Range	-55 to 150		°C	

P-Channel Enhancement Mode MOSFET

R₀JA	Thermal Resistance Junction-Ambient ¹	75	°C/W
R _θ JA	Thermal Resistance Junction-Ambient ¹ (t ≤10s)	30	°C/W
ReJC	Thermal Resistance Junction-Case ¹	3.36	°C/W

Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V
∆BVDSS/∆TJ	BVDSS Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.0232		V/°C
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-30A		9	13	mΩ
		V _{GS} =-4.5V , I _D =-15A		16	22	
V _{GS(th)}	Gate Threshold Voltage		-1.2		-2.5	V
$\triangle V_{\text{GS(th)}}$	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =-250uA		4.6		mV/°C
	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			-1	- uA
Ipss		V _{DS} =-24V , V _{GS} =0V , T _J =55°C			-5	
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-30A		30		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		9		Ω
Qg	Total Gate Charge (-4.5V)	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-		22		nC
Qgs	Gate-Source Charge			8.7		
Q_{gd}	Gate-Drain Charge			7.2		
Td(on)	Turn-On Delay Time			8		- ns
Tr	Rise Time	V_{DD} =-15V , V_{GS} =-10V R_{G} =3.3	,	73.7		
$T_{d(off)}$	Turn-Off Delay Time	RG=3.3 I _D =-15A		61.8		
Tf	Fall Time	- ID IOA		24.4		
Ciss	Input Capacitance			2215		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		310		pF
Crss	Reverse Transfer Capacitance			237		
ls	Continuous Source Current ^{1,5}	−V _G =V _D =0V , Force Current			-42	Α
Ism	Pulsed Source Current ^{2,5}				-130	Α
VsD	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1	V
trr	Reverse Recovery Time	IF=-15A , dI/dt=100A/μs ,		19		nS
Qrr	Reverse Recovery Charge	T _J =25°C		9		nC

Note:

^{1.}The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper. 2.The data tested by pulsed , pulse width ≤ 300 us duty cycle $\leq 2\%$ 3.The EAS data shows Max. rating . The test condition is V_{DD} =-25V V_{GS} =-10V,L=0.1mH,IAS=-50A,

^{4.}The power dissipation is limited by 150°C junction temperature

^{5.}The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.



Typical Characteristics

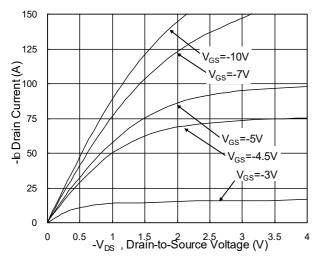


Fig.1 Typical Output Characteristics

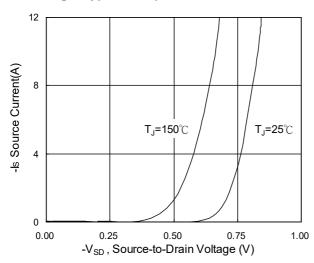


Fig.3 Forward Characteristics of Reverse

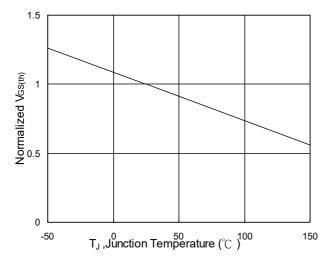


Fig.5 Normalized V_{GS(th)} vs. T_J

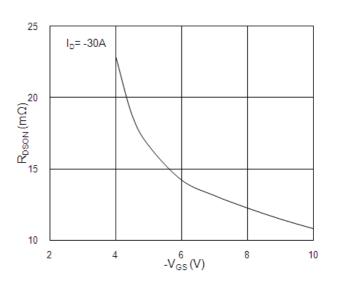


Fig.2 On-Resistance vs. G-S Voltage

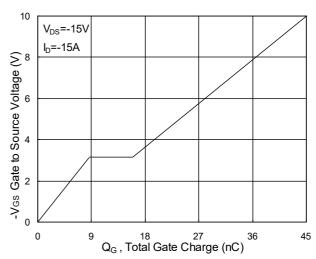


Fig.4 Gate-Charge Characteristics

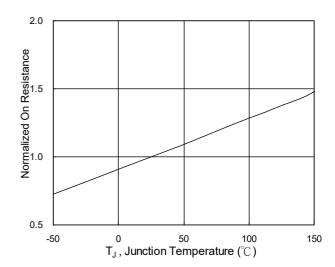
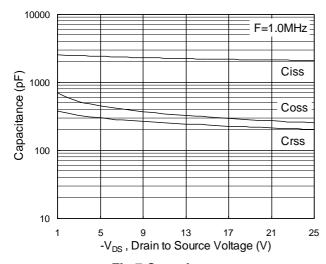


Fig.6 Normalized R_{DSON} vs. T_J



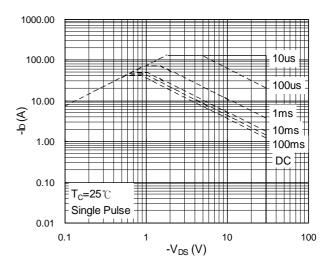


Fig.7 Capacitance

Fig.8 Safe Operating Area

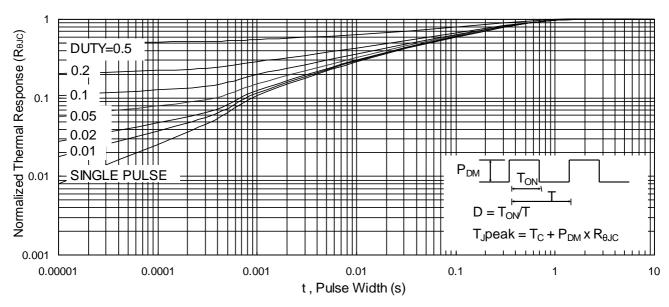


Fig.9 Normalized Maximum Transient Thermal Impedance

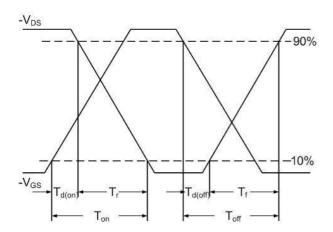


Fig.10 Switching Time Waveform

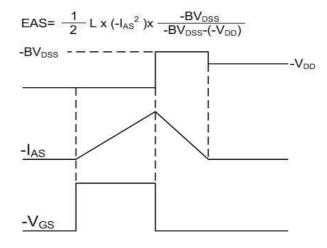
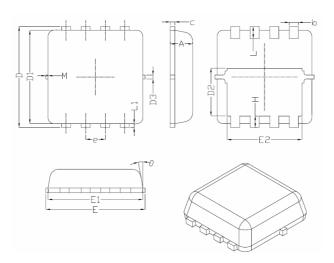


Fig.11 Unclamped Inductive Switching Waveform



DFN3X3-8L(Power-33-8) Package Information



Complete I	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
M	*	*	0.15	
θ		10 [°]	12 [°]	



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